



# Logic Locking a Design-for-Trust IC Design Technique

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## ► To cite this version:

Marie-Lise Flottes. Logic Locking a Design-for-Trust IC Design Technique. FETCH 2020 - École d'hiver Francophone sur les Technologies de Conception des Systèmes Embarqués Hétérogènes, Feb 2020, Montréal, Canada. lirmm-03125660

**HAL Id: lirmm-03125660**

**<https://hal-lirmm.ccsd.cnrs.fr/lirmm-03125660>**

Submitted on 29 Jan 2021

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# LOGIC LOCKING A DESIGN-FOR-TRUST IC DESIGN TECHNIQUE

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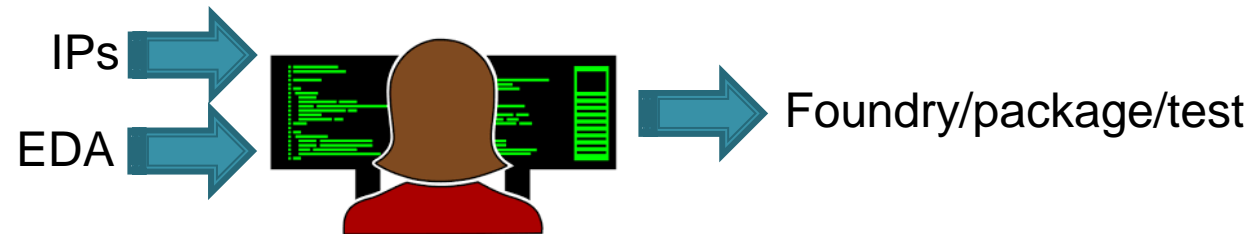
**FETCH 2020**

**École d'hiver Francophone sur les Technologies de Conception  
des Systèmes Embarqués Hétérogènes**

# COUNTERFEIT ICS: SOURCES & ISSUES

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- Source: profit + globalization



- Issues: Financial loss/Reliability/Security
  - Miss out \$100 billion/year
  - Reported counterfeit parts have been quadrupled since 2009
  - Many sectors are impacted (computers, telecom, automotive, .... military systems)
  - Dramatic consequences on critical systems

[0-3]



# TAXONOMY

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- Recycled/remarked components
  - Old components sold as new
  - New components sold with higher specification
    - commercial grade → industrial grade → defense grade
- Overproduction: Fabrication outside contract
  - Extra ICs or defective/out-of-spec components
- Cloning: Design copy
  - Reverse Engineering / IPs obtain illegally
- Tampered type: Hardware/Software Trojans (HT/ST)
  - Inserted at any level
  - Time bomb / back door



# COUNTERFEIT DETECTION

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- Physical detection
  - X-Ray, SEM
- Electrical detection
  - Parametric Tests / Functional tests



# COUNTERFEIT AVOIDANCE

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- *“Need for development of innovative avoidance mechanisms to be incorporated in the design”*
- (e.g. RO-Based) Sensors: Prevent die and IC recycling [15-16]
- Split manufacturing: Prevent overproduction [17]
- IC camouflaging: Prevent reverse engineering [18]
- Hardware watermarking: Secure IPs [19]
- Hardware metering:
  - Passive methods
    - Digitally stored serial numbers (nonfunctional identification)
    - PUF (functional identification)
  - Active methods: lock each IC until key is provided by the IP holder
    - Initialize IC to a locked state on power up
    - Add an FSM to unlock with the correct sequence to Initial State
    - Logic locking



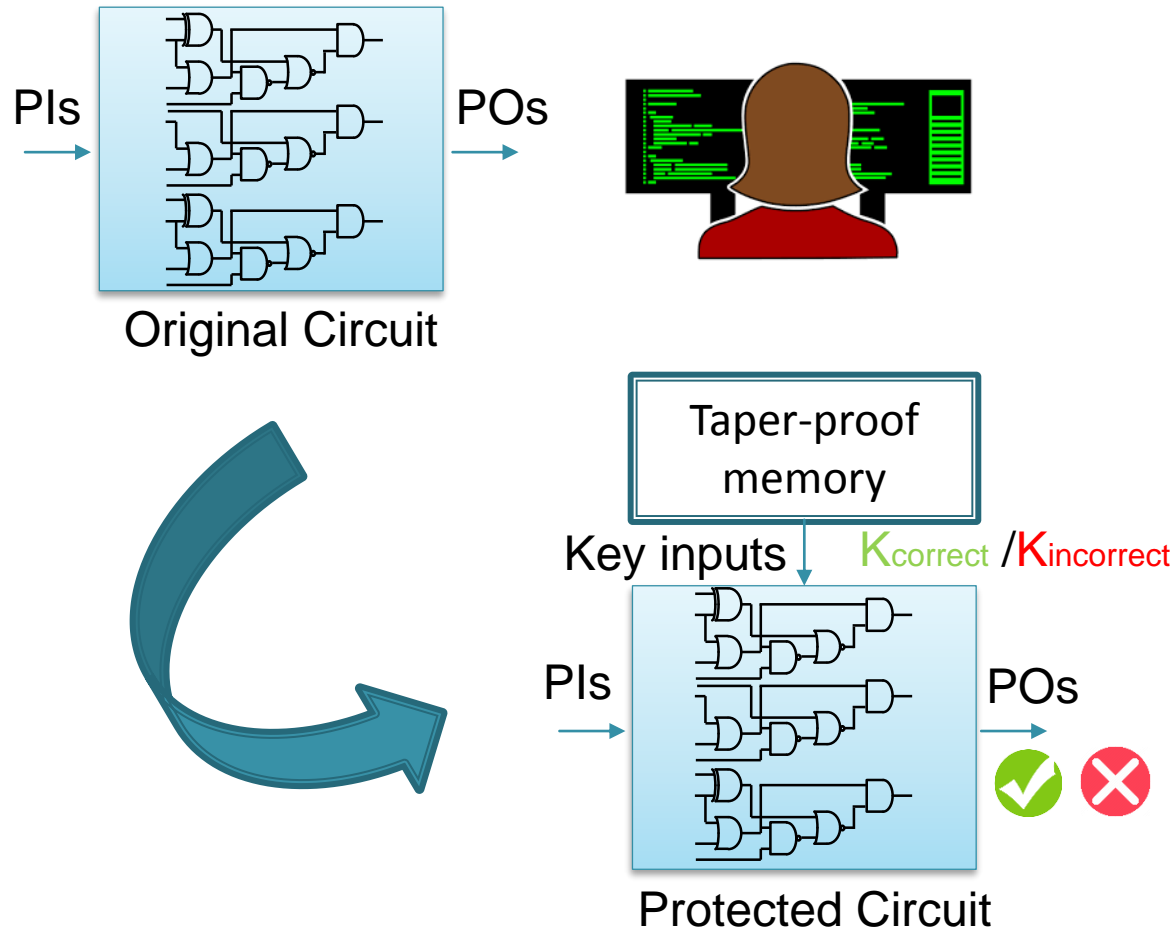
# OUTLINE

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- Principle
- Implementations
- SAT Attack on logic locking
- Improvement on logic locking solutions and other attacks
- Conclusions

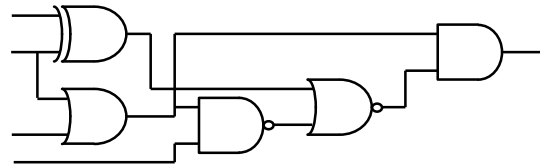


# TECHNICAL PRINCIPLE: KEYING MECHANISM

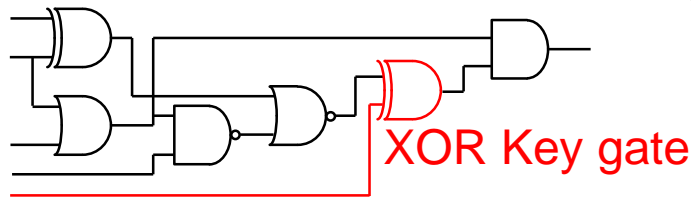




# TECHNICAL PRINCIPLE: KEY GATES & KEY BITS

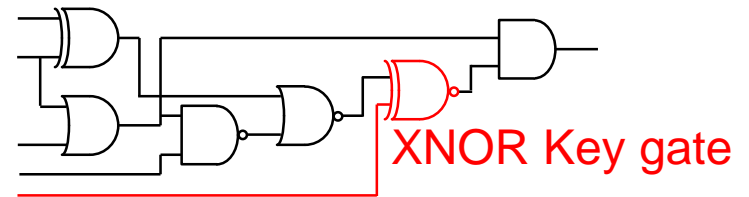


Original Circuit



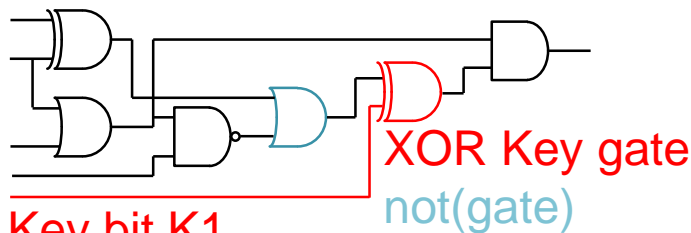
Key bit K1

K1=0 ✓ K1=1 ✗



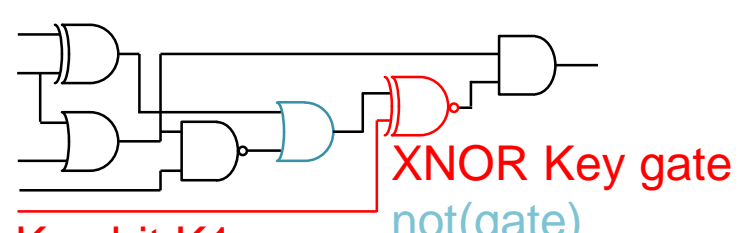
Key bit K1

K1=1 ✓ K1=0 ✗



Key bit K1

K1=1 ✓ K1=0 ✗



Key bit K1

K1=0 ✓ K1=1 ✗



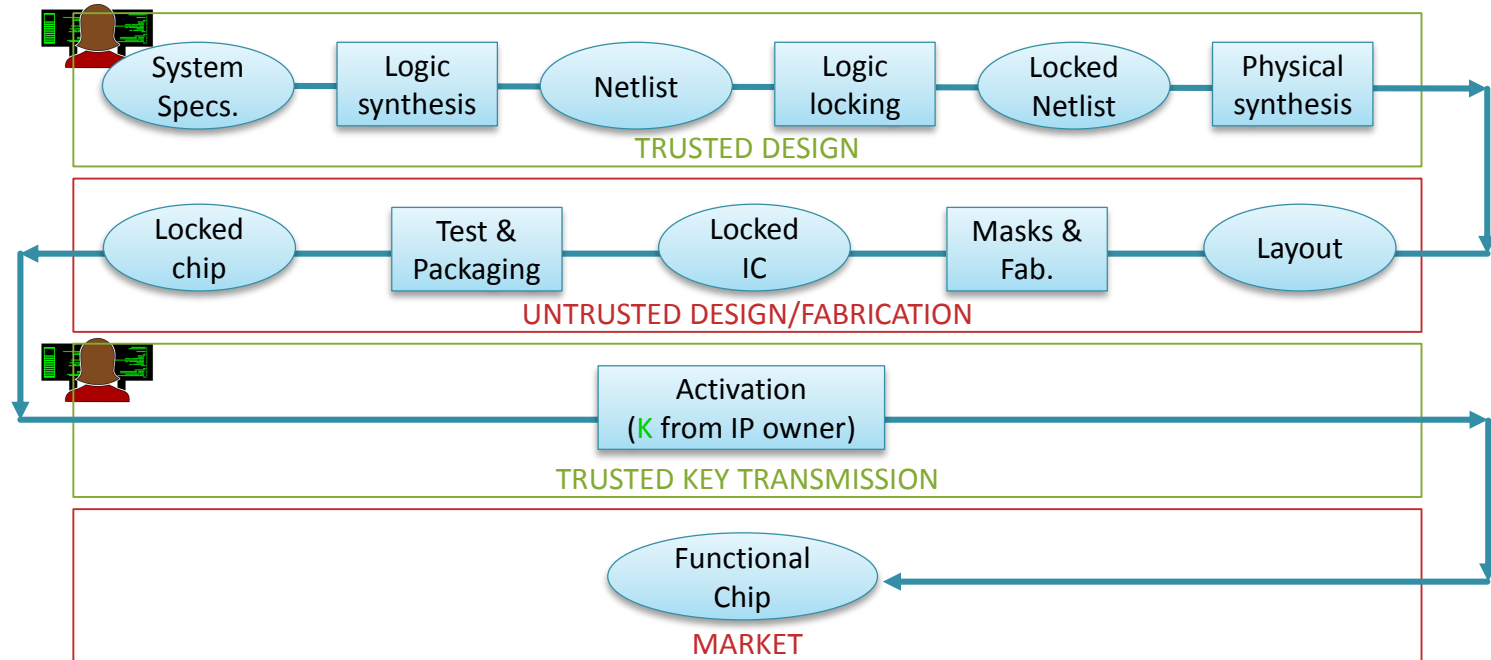
# EVALUATION

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- Output corruptibility
  - HD(corret outputs, incorrect outputs)
  - Optimum HD = 50% (maximal ambiguity)
- Security
  - Possibilities to penetrate the system using techniques available to an attacker



# APPLICATION PRINCIPLE IN THE IC DESIGN FLOW

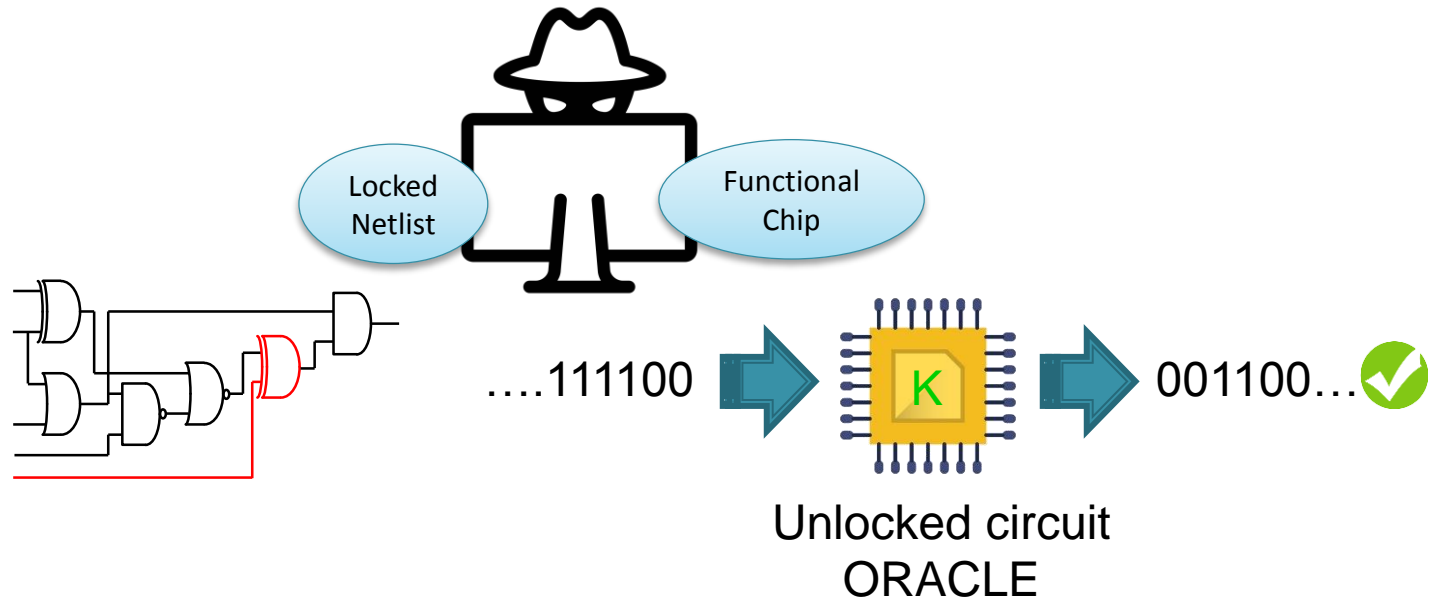


- ✓ Prevents from Reverse Engineering
- ✓ Prevents from Overproduction
- ✓ Makes harder identification of 'safe place' for HT insertion



# ASSUMPTION ON LOGIC LOCKING ATTACKS

- Acker knows the locked netlist / has an unlocked circuit (**K** inside)



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# IMPLEMENTATION(S)

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- First 2010
  - [6] « EPIC : Ending Piracy of Integrated Circuits »
    - **RLL: Random Logic locking**
    - Introduce k XOR/NXOR key-gates at random locations (while meeting timing constraints)
  - [7] « Preventing IC Piracy Using Reconfigurable Logic Barriers »
    - **LUT-based locking** (Correct/incorrect LUT programming provide modification of the information flow)
    - Introduce LUT at choosen location for maximum attacker effort (low-controllable nodes), and for optimal output corruption (high observable nodes)



# IMPLEMENTATION(S) CONT'D

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- First improvements (output corruption)
  - [8] 2015 « Fault Analysis-Based Logic Encryption »
    - **FLL: Fault-Analysis-based logic locking**
    - Introduce  $k$  XOR/NXOR key-gates at choosen locations for optimal output corruption
    - Metric (maximal number of patterns  $NC$  to control the node & maximal number of affected primary outputs  $NO$ )
    - Highest FI =  $NC_0 \times NO_0 + NC_1 \times NO_1$
  - [9] Variante 2017
    - **WLL: Weighted logic locking**
    - XOR key-gates fed by multiple key-bits through additional AND/OR gates which leads to a higher output corruptibility

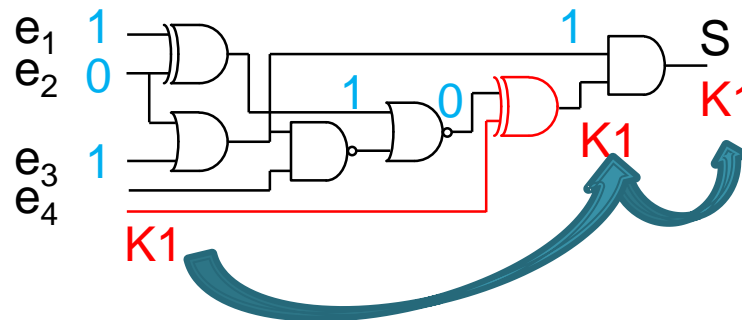


# IMPLEMENTATION(S) CONT'D

- First improvements (security)

- [10-11] 2012-2016

- Issue



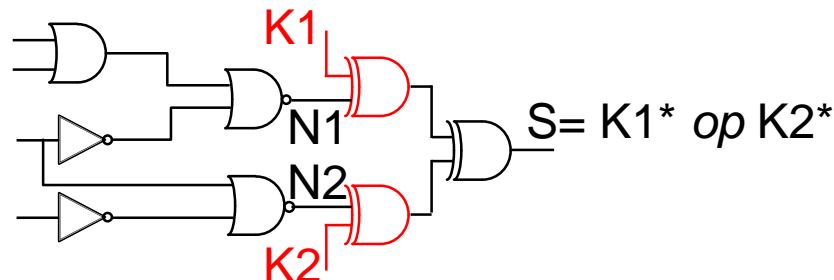
Input Patterns  
 $(e_1, e_2, e_3, e_4) = (1, 0, 1, x)$



$S = K1 !$

- SLL: Strong Logic Locking**

Introduce XOR/NXOR key-gates at chosen locations for ensuring interdependence among key bits





# OUTLINE

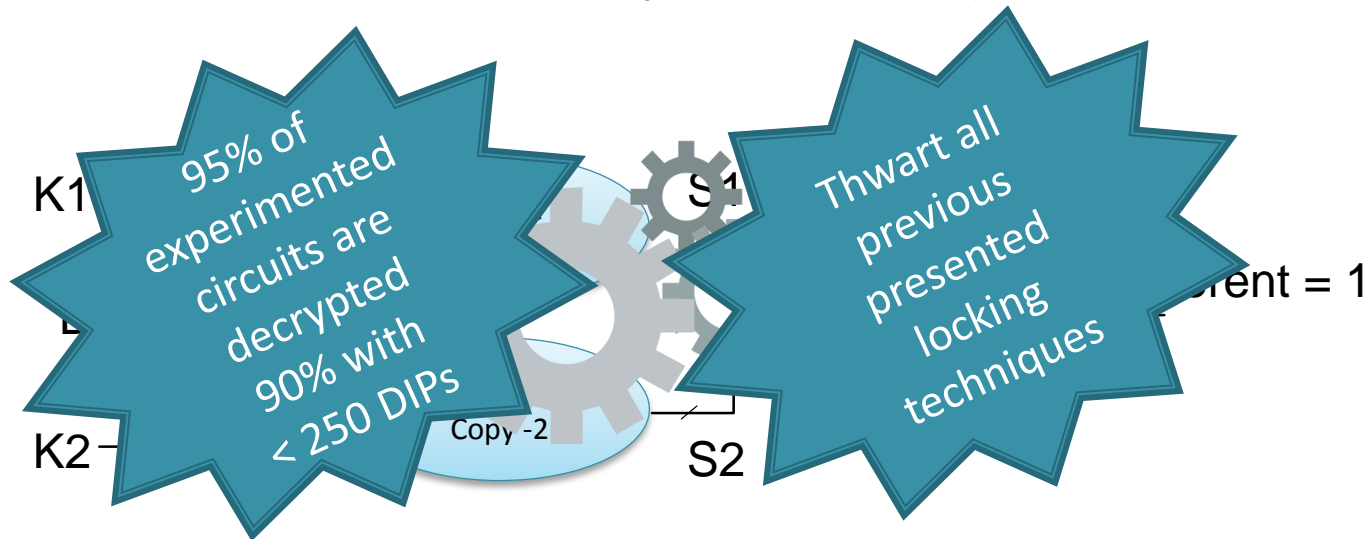
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# SAT ATTACK

- Boolean Satisfiability attack (SAT attack [12] 2015): Iteratively rules out incorrect keys
  - 1/ Found a DIP (Differential Input Pattern) /  $f(\text{DIP}, K1) \neq f(\text{DIP}, K2)$



- 2/ Compare  $f(\text{DIP}, K_i)$  with Oracle(DIP)
  - If  $f(\text{DIP}, K_i) \neq \text{Oracle}(\text{DIP})$ ,  $K_i$  can be rejected
- 3/ Iterate until no more DIP is found
  - All incorrect keys have been rejected



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# POST-SAT-ATTACK SOLUTIONS

- Resisting the SAT-attack by increasing its Execution time

$$\text{SAT Execution Time: } ET = \sum_{i=1}^{iter} ti$$

- ⇒ Controlling the distinguishing ability of DIPs
- ⇒ Rule out at most one incorrect key per DIP

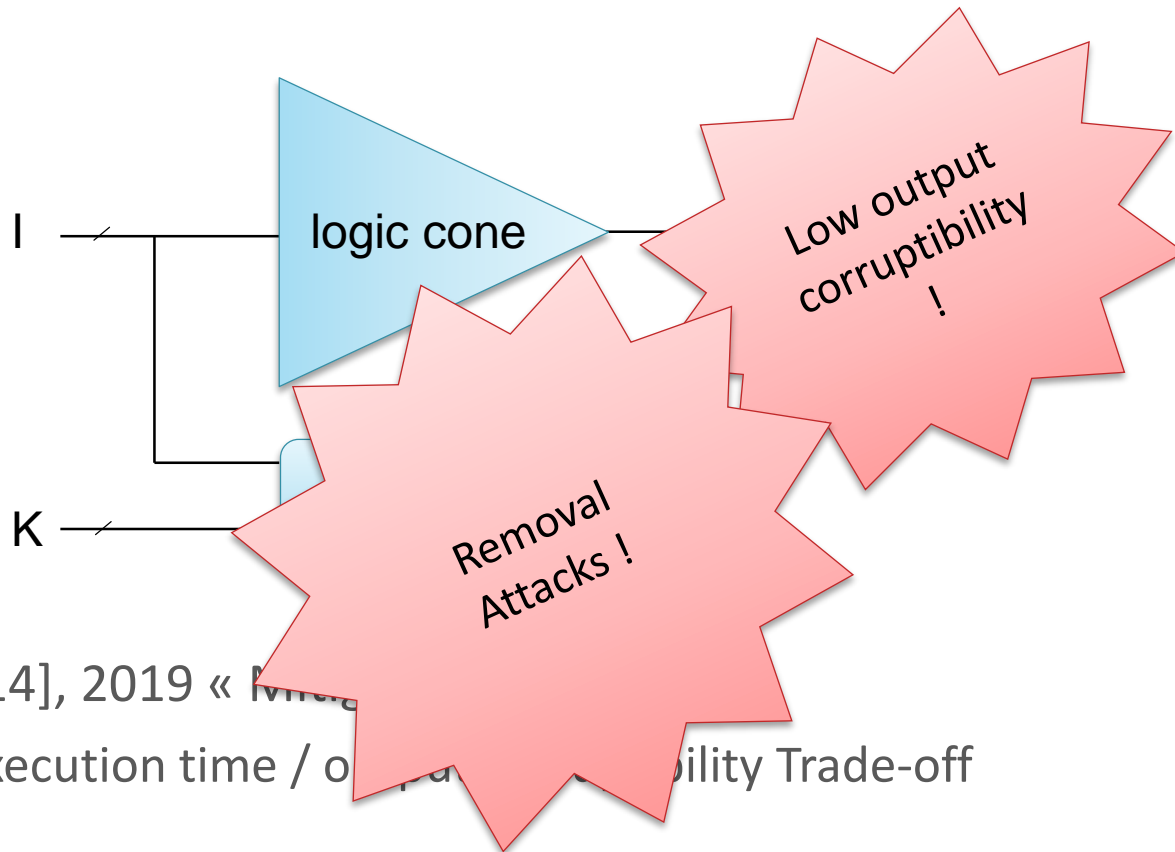
Inputs			Original O	O for ki							
I1	I2	I3		K0	K1	K2	K3	K4	K5	K6	K7
0	0	0	0	1	0	0	0	0	0	0	0
0	0	1	1	1	0	1	1	1	1	1	1
0	1	0	1	1	1	0	1	1	1	1	1
0	1	1	0	0	0	0	1	0	0	0	0
1	0	0	0	0	0	0	0	0	0	0	0
1	0	1	0	0	0	0	0	0	1	0	0
1	1	0	1	1	1	1	1	1	1	0	1
1	1	1	0	0	0	0	0	0	0	0	1

$2^k - 1$  DIPs to succeed !



# POST-SAT-ATTACK SOLUTIONS (CONT'D)

- SARLock [13], 2016 « SAT Attack Resilient logic locking »



- Anti-SAT, [14], 2019 « Mixed SAT Execution time / output quality Trade-off »
- SAT Execution time / output quality Trade-off



# OTHER ATTACKS ON LOGIC LOCKING

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- Removal attacks
  - remove locking mechanisms from the studied netlist
- Approximate attacks on compound logic locking techniques (eg SARLock+FLL)
  - returns an approximate key (only FLL key bits are extracted) leaving the low-corruptability constituent in the netlist (SARLock countermeasure)
- Power side-channel attacks
- Oracle-less attacks (e.g. redundancy identification)



# CONCLUSION

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## ○ Design for Trust (DfTr)

- Watermarking that embeds a designer's signature into the design
- Passive metering that enables tracking of individual ICs throughout the lifetime
- Camouflaging that introduces look-alike structures at the layout-level
- Split manufacturing that involves partial fabrication at two separate foundries
- And...



## ○ Logic locking

- Locks a design with key-controlled protection logic
- Protection anywhere in the supply chain
  - Rogue SoC integrator (IP reuse)
  - Untrusted foundry (overproduction, HT)
  - Untrusted test facility (sell defective parts, recycling)
  - Malicious end-user (replicate)



# WORK IN PROGRESS

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- All logic Locking solutions exhibit specific weakness
- No metrics
- May exhibit vulnerabilities after implementation
- Implementation Cost





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# Merci !



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